



STM303P150LSH8H

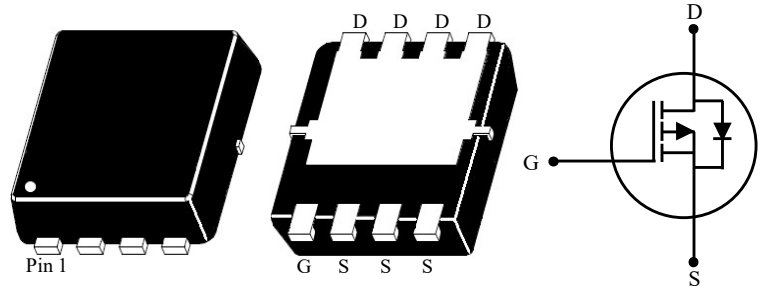
P-Channel Enhancement Mode Field Effect Transistor

FEATURES

- Low $R_{DS(on)}$
- Suffix "H" indicates Halogen-free parts, ex.STM303P150LSH8H

PIN CONFIGURATION

DFN3x3-8L



| | |
|---|--------|
| D | Drain |
| G | Gate |
| S | Source |

Maximum Ratings ($T_A = 25\text{ }^\circ\text{C}$ unless otherwise noted)

| Parameter | Symbol | Value | Unit | |
|------------------------------------------------------|-----------------|-----------------------------------|---------------------------|---|
| Drain-Source Voltage | V_{DS} | -30 | V | |
| Gate-Source Voltage | V_{GS} | ± 20 | | |
| Drain Current | I_D | $T_C = 25\text{ }^\circ\text{C}$ | -44 | A |
| | | $T_C = 100\text{ }^\circ\text{C}$ | -27 | |
| Pulsed Drain Current (Note 1) | I_{DM} | -150 | A | |
| Avalanche Current | I_{AS} | -27 | A | |
| Avalanche Energy (Note 2) | E_{AS} | 36.4 | mJ | |
| Power Dissipation | P_D | 33.7 | W | |
| Thermal Resistance from Junction to Ambient (Note 3) | $R_{\theta JA}$ | 45 | $^\circ\text{C}/\text{W}$ | |
| Thermal Resistance from Junction to Case | $R_{\theta JC}$ | 3.7 | $^\circ\text{C}/\text{W}$ | |
| Operating Junction and Storage Temperature Range | T_J, T_{stg} | - 55 to + 150 | $^\circ\text{C}$ | |

Note:

1. The data tested by pulsed, pulse width $\leq 100\mu\text{s}$, duty cycle $\leq 2\%$, Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)} = 150\text{ }^\circ\text{C}$
2. Limited by $T_{J(MAX)}$, starting $T_J = 25\text{ }^\circ\text{C}$, $L = 0.1\text{mH}$, $R_g = 25\Omega$, $I_{AS} = -27\text{A}$, $V_{GS} = -10\text{V}$.
3. Device mounted on FR-4 substrate PC board, 2oz copper, with 1 inch² copper plate in still air.



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Electrical Characteristics ($T_A = 25\text{ }^\circ\text{C}$ unless otherwise specified)

| Parameter | Conditions | Symbol | Min. | Typ. | Max. | Unit |
|----------------------------------|--------------------------------------------------------------------------------------|---------------|------|------|-----------|---------------|
| Static | | | | | | |
| Drain-Source Breakdown Voltage | $I_D = -250\mu\text{A}$ | $V_{(BR)DSS}$ | -30 | - | - | V |
| Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = -250\mu\text{A}$ | $V_{GS(th)}$ | -1.0 | - | -2.5 | V |
| Zero Gate Voltage Drain Current | $V_{DS} = -30\text{V}$ | I_{DSS} | - | - | -1 | μA |
| Gate Leakage Current | $V_{GS} = \pm 20\text{V}$ | I_{GSS} | - | - | ± 100 | nA |
| Drain-Source On-Resistance | $V_{GS} = -10\text{V}, I_D = -15\text{A}$ | $R_{DS(on)}$ | - | 12 | 15 | m Ω |
| | $V_{GS} = -4.5\text{V}, I_D = -10\text{A}$ | | - | - | 18 | |
| Forward Transconductance | $V_{DS} = -5\text{V}, I_D = -10\text{A}$ | g_{FS} | - | 23.5 | - | S |
| Dynamic | | | | | | |
| Gate Resistance | $V_{DS} = 0\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$ | R_g | - | 4.2 | - | Ω |
| Total Gate Charge | $V_{DS} = -15\text{V}, V_{GS} = -4.5\text{V}, I_D = -15\text{A}$ | Q_g | - | 21 | - | nC |
| | | Q_{gs} | - | 43 | - | |
| | | Q_{gd} | - | 8 | - | |
| Gate-Source Charge | $V_{DS} = -15\text{V}, V_{GS} = -10\text{V}, I_D = -15\text{A}$ | Q_{gs} | - | 8 | - | pF |
| Gate-Drain Charge | | Q_{gd} | - | 8 | - | |
| Input Capacitance | $V_{DS} = -15\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$ | C_{iss} | - | 2363 | - | |
| Output Capacitance | | C_{oss} | - | 244 | - | |
| Reverse Transfer Capacitance | | C_{rss} | - | 184 | - | |
| Turn on Delay Time | $V_{DS} = -15\text{V}, I_D = -15\text{A}$ $V_{GS} = -10\text{V}, R_g = 3.3\Omega$ | $t_{d(on)}$ | - | 13 | - | ns |
| Turn on Rise Time | | t_r | - | 44 | - | |
| Turn off Delay Time | | $t_{d(off)}$ | - | 26 | - | |
| Turn off Fall Time | | t_f | - | 7 | - | |
| Drain-Source Body Diode | | | | | | |
| Diode Forward Voltage | $V_{GS} = 0\text{V}, I_S = -1\text{A}$ | V_{SD} | - | - | -1.0 | V |
| Diode Continuous Forward Current | - | I_S | - | - | -44 | A |
| Diode Pulse Current | | I_{SM} | - | - | -150 | A |
| Reverse Recovery Time | $I_S = -15\text{A}, di/dt = 100\text{A}/\mu\text{s}$ | t_{rr} | - | 14 | - | ns |
| Reverse Recovery Charge | | Q_{rr} | - | 7 | - | nC |



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RATINGS AND CHARACTERISTIC CURVES

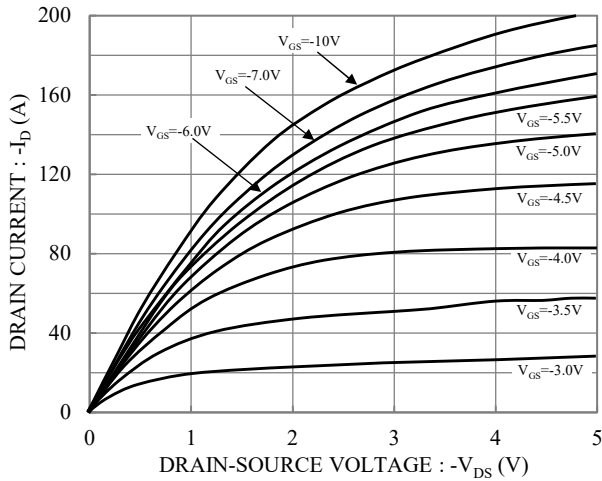


Fig.1 Typical Output Characteristics

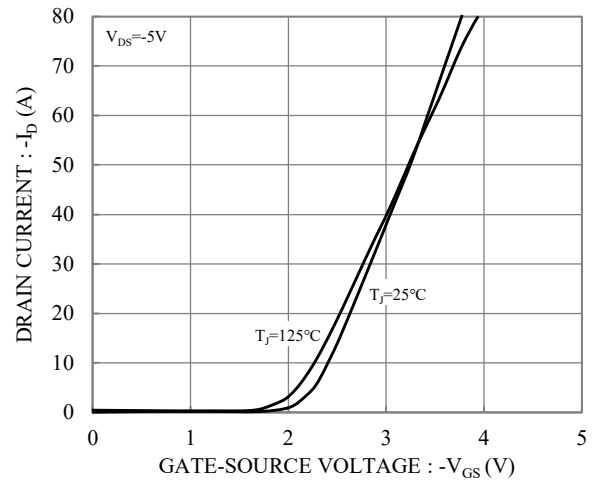


Fig.2 Typical Transfer Characteristics

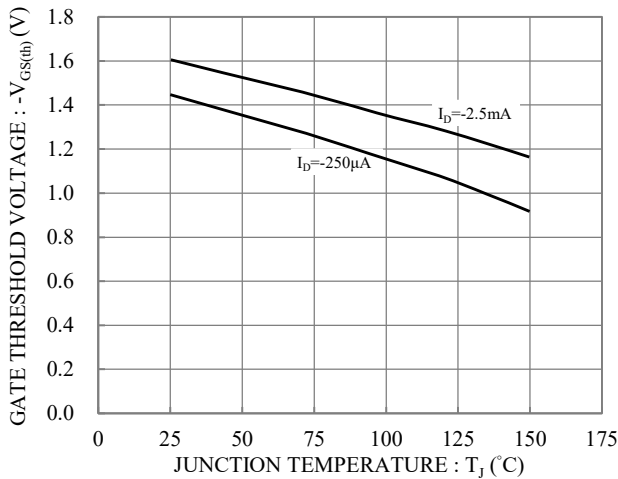


Fig.3 Gate Threshold Voltage vs. Junction Temperature

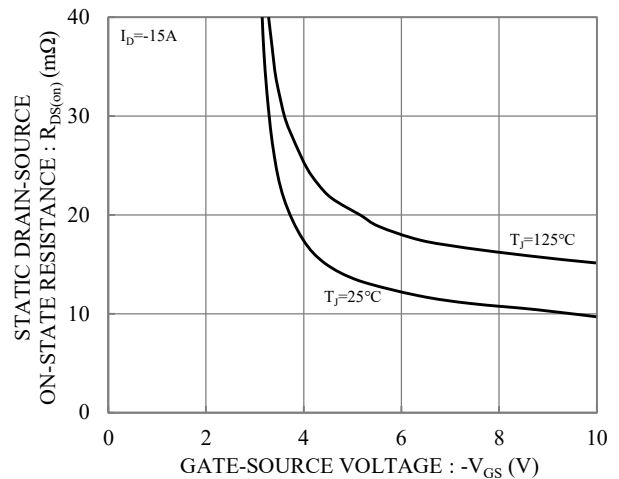


Fig.4 Static Drain-Source On-State Resistance vs. Gate-Source Voltage

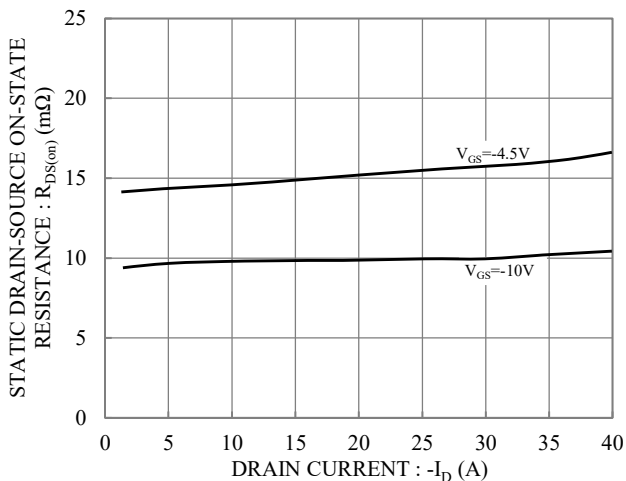


Fig.5 Static Drain-Source On-State Resistance vs. Drain Current

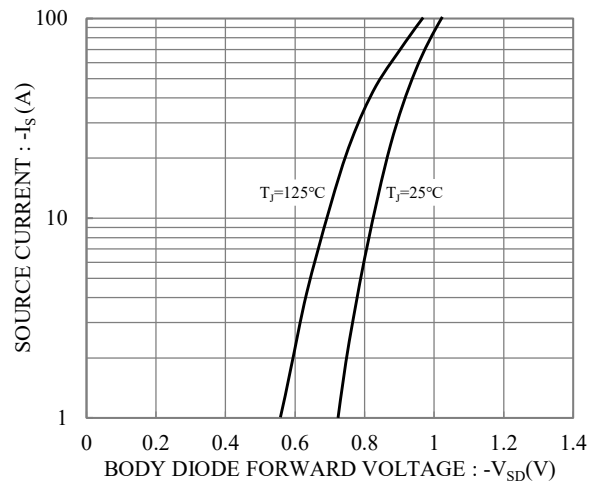


Fig.6 Body Diode Forward Voltage vs. Source Current



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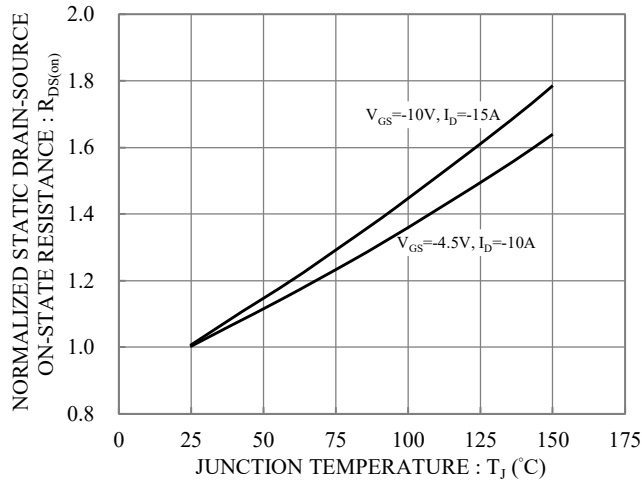


Fig.7 Drain-Source On-State Resistance vs. Junction Temperature

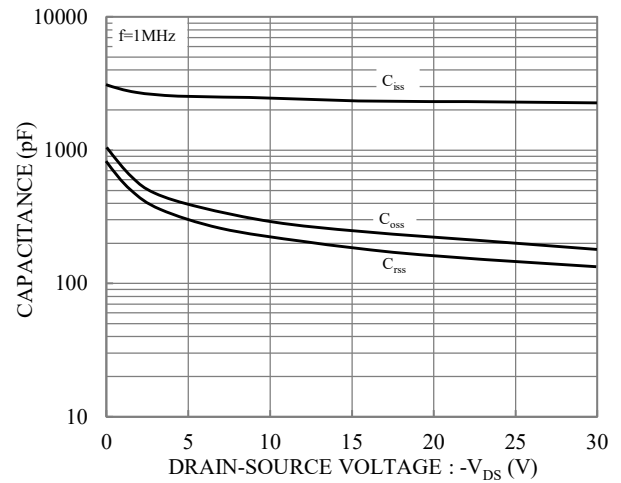


Fig.8 Capacitance vs. Drain-Source Voltage

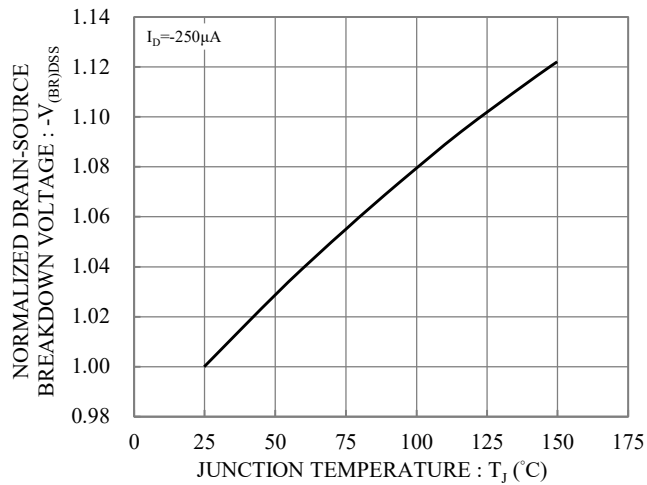


Fig.9 Breakdown Voltage vs. Junction Temperature

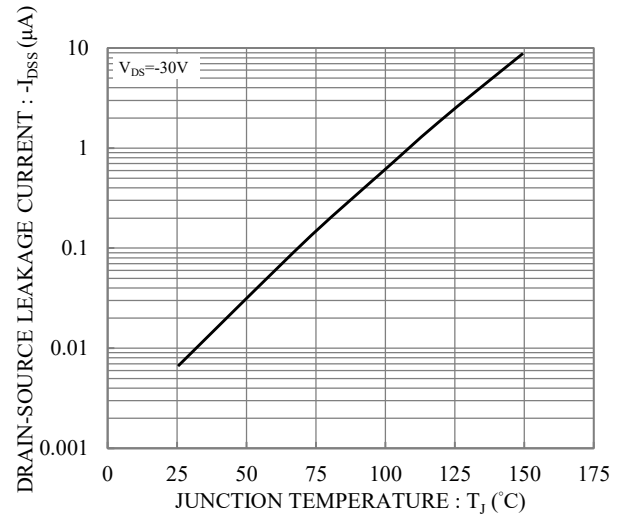


Fig.10 Drain-Source Leakage Current vs. Junction Temperature

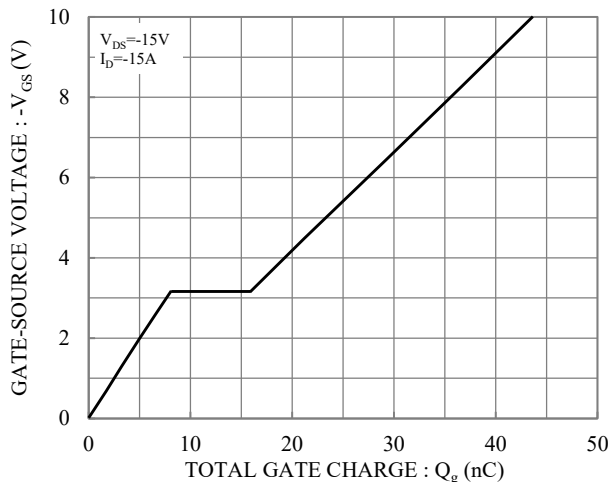


Fig.11 Gate Charge Characteristics

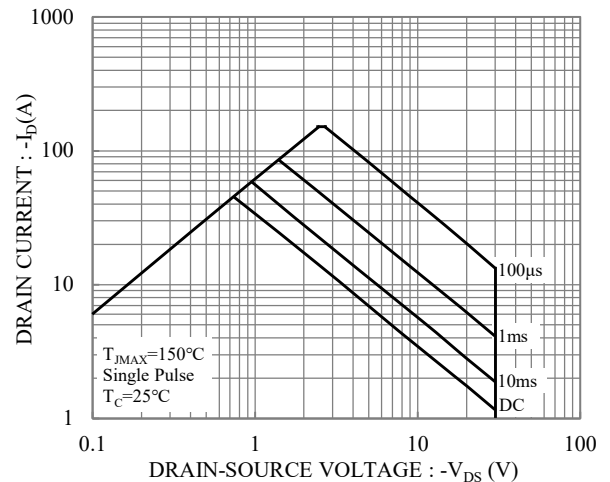


Fig.12 Safe Operation Area



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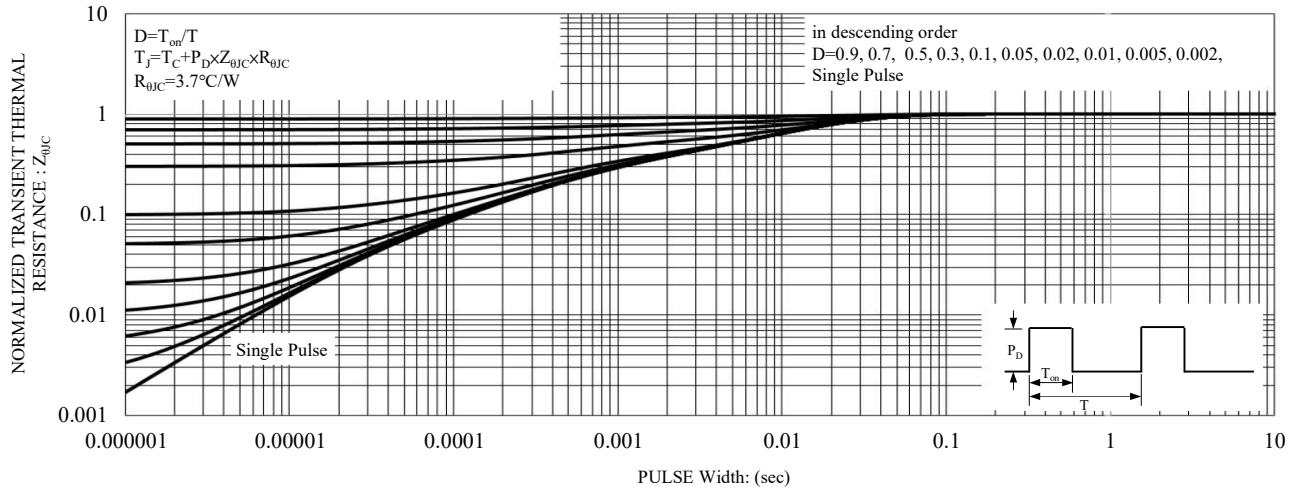


Fig.13 Maximum Transient Thermal Impedance

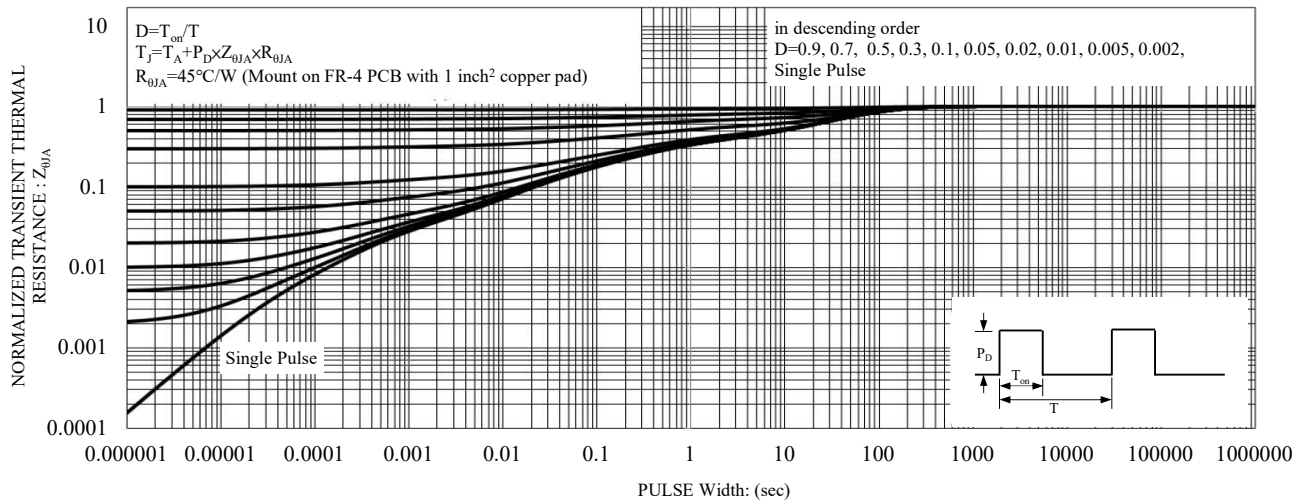


Fig.14 Maximum Transient Thermal Impedance

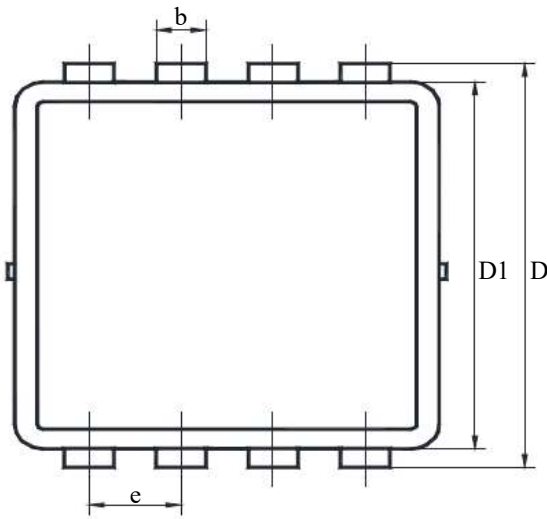


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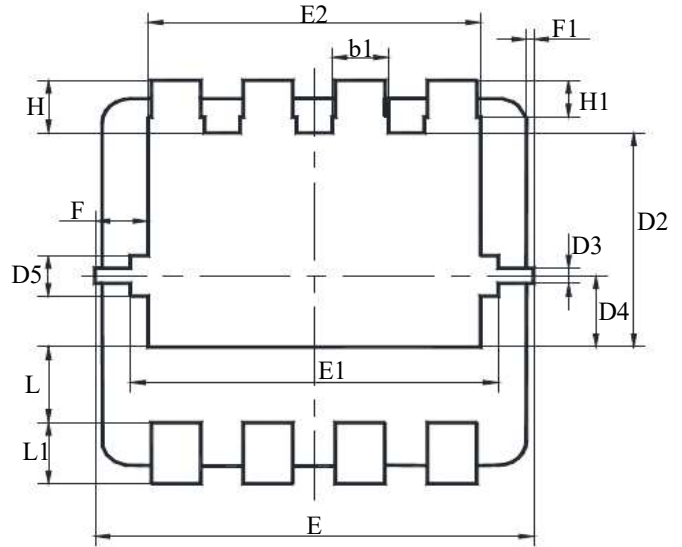
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PACKAGE DIMENSION

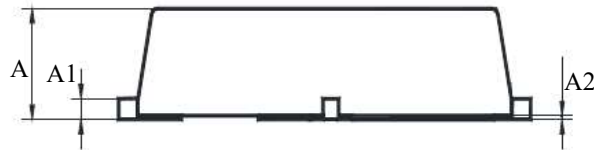
DFN3×3-8L



Top View



Bottom View



Side View

| Symbol | Millimeters | | Inches | |
|-----------|-------------|-------|--------|-------|
| | Min | Max | Min | Max |
| A | 0.700 | 0.900 | 0.028 | 0.035 |
| A1 | 0.100 | 0.250 | 0.004 | 0.010 |
| A2 | 0.000 | 0.050 | 0.000 | 0.002 |
| b | 0.240 | 0.350 | 0.009 | 0.014 |
| b1 | 0.300 | 0.500 | 0.012 | 0.020 |
| D | 3.100 | 3.300 | 0.122 | 0.130 |
| D1 | 2.900 | 3.100 | 0.114 | 0.122 |
| D2 | 1.650 | 1.850 | 0.065 | 0.073 |
| D3 | 0.150 | 0.250 | 0.006 | 0.010 |
| D4 | 0.480 | 0.680 | 0.019 | 0.027 |
| D5 | 0.230 | 0.430 | 0.009 | 0.017 |
| E | 3.000 | 3.200 | 0.118 | 0.126 |
| E1 | 2.500 | 2.700 | 0.098 | 0.106 |
| E2 | 2.400 | 2.600 | 0.094 | 0.102 |
| e | 0.600 | 0.700 | 0.024 | 0.028 |
| F | 0.275 | 0.475 | 0.011 | 0.019 |
| F1 | 0.000 | 0.100 | 0.000 | 0.004 |
| L | 0.520 | 0.720 | 0.020 | 0.028 |
| L1 | 0.300 | 0.500 | 0.012 | 0.020 |
| H | 0.330 | 0.530 | 0.013 | 0.021 |
| H1 | 0.200 | 0.400 | 0.008 | 0.016 |



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SUGGESTED SOLDER PAD LAYOUT

